Search Notes			

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/740,698	VARNER ET AL.	
	Examiner	Art Unit	
	Benjamin Huh	3767	

	SEAR	CHED	
Class	Subclass	Date	Examiner
604	890.1, 891.1, 93.01, 521	6/30/2006	внн
424	427-428	6/30/2006	внн
424	422	6/30/2006	внн
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Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAF	NOTES RCH STRATEGY)
	DATE	EXMR
EAST	6/30/2006	внн
Search History Updated	3/10/2007	внн